Application/Control No. Applicant(s)/Patent Under Reexamination 10/651,151 CHEN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Thuan Do 2825 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2003/0222872 12-2003 Lin et al. 345/440 Α * В US-4,656,592 04-1987 Spaanenburg et al. 716/7 С US-US-D US-Ε F US-US-G US-Н US-US-US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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